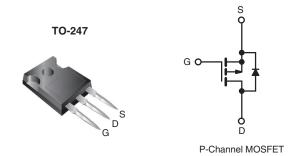


Vishay Siliconix

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	- 100			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = - 10 V	0.20		
Q _g (Max.) (nC)	61			
Q _{gs} (nC)	14			
Q _{gd} (nC)	29			
Configuration	Single			



FEATURES

- Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- P-Channel
- · Isolated Central Mounting Hole
- 175 °C Operating Temperature
- · Fast Switching
- · Ease of Paralleling
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mouting hole. It also provides greater creepage distance between pins to meet the requirements of most safety specifications.

ORDERING INFORMATION	
Package	TO-247
Lead (Pb)-free	IRFP9140PbF
	SiHFP9140-E3
SnPb	IRFP9140
	SiHFP9140

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V_{DS}	- 100	V	
Gate-Source Voltage	V_{GS}	± 20	7 v		
Continuous Drain Current	V_{GS} at - 10 V $\frac{T_C = 25 ^{\circ}\text{C}}{T_C = 100 ^{\circ}\text{C}}$	1	- 21	А	
	V_{GS} at - 10 V_{C} T_{C} = 100 °C	I _D	- 15		
Pulsed Drain Current ^a	I _{DM}	- 84			
Linear Derating Factor			1.2	W/°C	
Single Pulse Avalanche Energy ^b	E _{AS}	960	mJ		
Repetitive Avalanche Current ^a	I _{AR}	- 21	Α		
Repetitive Avalanche Energy ^a		E _{AR}	18	mJ	
Maximum Power Dissipation	T _C = 25 °C	P_D	180	W	
Peak Diode Recovery dV/dt ^c	dV/dt	- 5.5	V/ns		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d]	
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
Mounting Torque	0-32 OF IVIS SCIEW		1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD} = -25 \text{ V}$, starting $T_J = 25 \,^{\circ}\text{C}$, $L = 3.3 \,^{\circ}\text{mH}$, $R_G = 25 \,^{\circ}\Omega$, $I_{AS} = -21 \,^{\circ}\text{A}$ (see fig. 12).
- c. $I_{SD} \le$ 21 A, $dI/dt \le$ 200 A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le$ 175 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFP9140, SiHFP9140

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THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	40	
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.83	

SPECIFICATIONS $T_J = 25 ^{\circ}C$,				MIN.		l	T
PARAMETER	SYMBOL	TEST	TEST CONDITIONS		TYP.	MAX.	UNIT
Static		_			1	•	
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		- 100	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to	o 25 °C, I _D = - 1 mA	-	- 0.087	-	V/°C
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{C}$	$V_{DS} = V_{GS}, I_D = -250 \mu A$		-	- 4.0	V
Gate-Source Leakage	I _{GSS}	V _G	S = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		V _{DS} = - 100 V, V _{GS} = 0 V V _{DS} = - 80 V, V _{GS} = 0 V, T _J = 150 °C		-	- 100 - 500	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	_	I _D = - 13 A ^b	-	-	0.20	Ω
Forward Transconductance	9 _{fs}	$V_{DS} = -50 \text{ V}, I_{D} = -13 \text{ A}^{b}$		6.2	_	-	S
Dynamic	0.0	20				l	
Input Capacitance	C _{iss}			_	1400	_	1
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = -25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	590	-	pF
Reverse Transfer Capacitance	C _{rss}			-	140	-	1
Total Gate Charge	Qq		V _{GS} = -10 V	_	-	61	nC
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V		-	-	14	
Gate-Drain Charge	Q _{gd}	see fig. 6 and 13 ^b	-	-	29	1	
Turn-On Delay Time	t _{d(on)}			-	16	-	
Rise Time	t _r	\/ F	V 50 V 1 40 A		73	-	ns
Turn-Off Delay Time	t _{d(off)}	V_{DD} = - 50 V, I_{D} = - 19 A, R_{G} = 9.1 Ω , R_{D} = 2.4 Ω , see fig. 10 ^b		-	34	-	
Fall Time	t _f			-	57	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	nH
Internal Source Inductance	Ls			-	13	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	- 21	Α
Pulsed Diode Forward Current ^a	I _{SM}			-	-	- 84	
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = -21 A, V _{GS} = 0 V ^b		-	-	- 5.0	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = -19 A, dl/dt = 100 A/μs ^b		-	130	260	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.35	0.70	μС
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D				L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

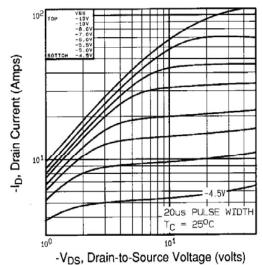


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

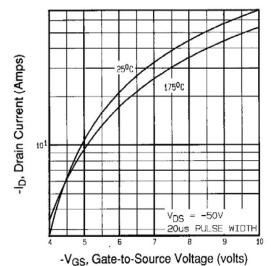


Fig. 3 - Typical Transfer Characteristics

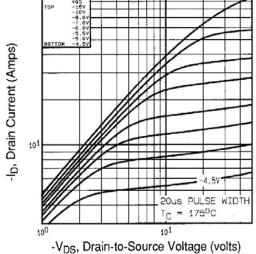


Fig. 2 - Typical Output Characteristics, $T_C = 175$ °C

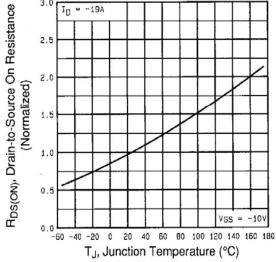


Fig. 4 - Normalized On-Resistance vs. Temperature

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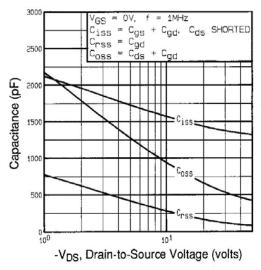


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

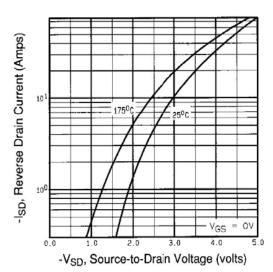


Fig. 7 - Typical Source-Drain Diode Forward Voltage

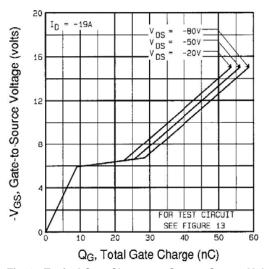


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

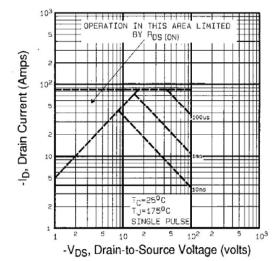


Fig. 8 - Maximum Safe Operating Area





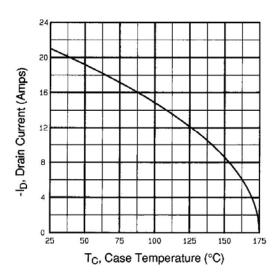


Fig. 9 - Maximum Drain Current vs. Case Temperature

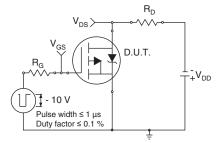


Fig. 10a - Switching Time Test Circuit

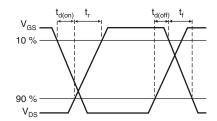


Fig. 10b - Switching Time Waveforms

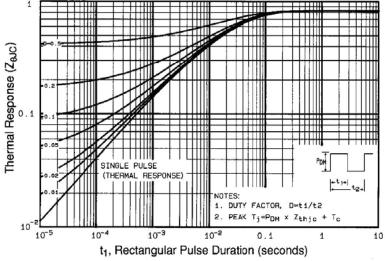


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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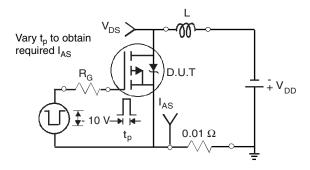


Fig. 12a - Unclamped Inductive Test Circuit

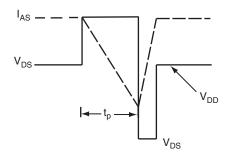


Fig. 12b - Unclamped Inductive Waveforms

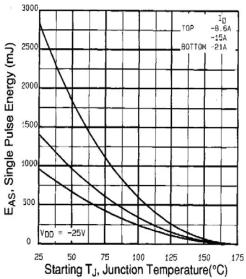


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

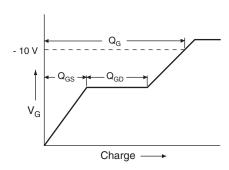


Fig. 13a - Basic Gate Charge Waveform

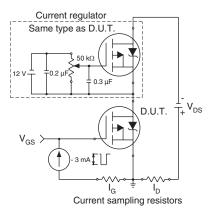
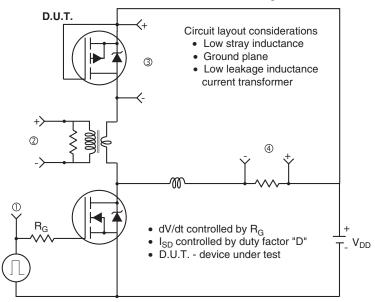


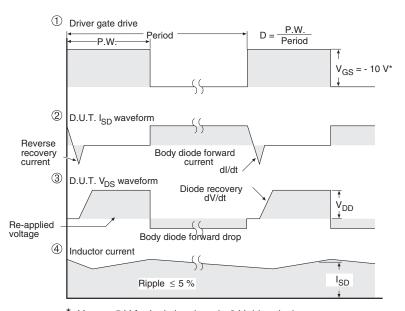
Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver



 * V_{GS} = -5 V for logic level and -3 V drive devices

Fig. 14 - For P-Channel

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